Power MOSFET

30 V, 48 A, Single N–Channel, SO–8 FL Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Dual Sided Cooling Capability
- Optimized for 5 V, 12 V Gate Drives
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- CPU Power Delivery
- DC–DC Converters
- **MAXIMUM RATINGS** (T₁ = 25°C unless otherwise stated)

			1	,	
Para	meter		Symbol	Value	Unit
Drain-to-Source Volt	age		V _{DSS}	30	V
Gate-to-Source Volta	age		V _{GS}	±20	V
Continuous Drain		T _A = 25°C	۱ _D	16.7	Α
Current R _{θJA} (Note 1)		T _A = 100°C		10.5	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	2.70	W
Continuous Drain		T _A = 25°C	Ι _D	25.2	А
Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)	Steady State	T _A = 100°C		15.9	
Power Dissipation $R_{\theta JA} \leq 10 \text{ s} \text{ (Note 1)}$		T _A = 25°C	PD	6.16	W
Continuous Drain	Steady State $T_A = 25^{\circ}$ ackage nd Storage y Diode) DT o-Source A $f_{DD} = 24 \text{ V},$ nH, R _G = 25 r Soldering	T _A = 25°C	۱ _D	9.7	Α
Current R _{θJA} (Note 2)		T _A = 100°C		6.2	
Power Dissipation $R_{\theta JA}$ (Note 2)		T _A = 25°C	PD	0.92	W
Continuous Drain		T _C = 25°C	Ι _D	48	Α
Current R _{θJC} (Note 1)		T _C =100°C		30	
Power Dissipation $R_{\theta JC}$ (Note 1)	T _A = 25°	T _C = 25°C	PD	23.2	W
Pulsed Drain Current	T _A = 25°	°C, t _p = 10 μs	I _{DM}	195	A
Current Limited by Pa		T _A = 25°C	I _{Dmax}	100	Α
Operating Junction ar Temperature	nd Storage	!	T _J , T _{STG}	–55 to +150	°C
Source Current (Body	/ Diode)		ا _S	21	Α
Drain to Source DV/D	T		dV/d _t	6.0	V/ns
Single Pulse Drain-to-Source Avalanche Energy (T _J = 25°C, V _{DD} = 24 V, V _{GS} = 10 V, I _L = 26 A _{pk} , L = 0.1 mH, R _G = 25 Ω)		E _{AS}	34	mJ	
Lead Temperature for (1/8" from case for 10		Purposes	ΤL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

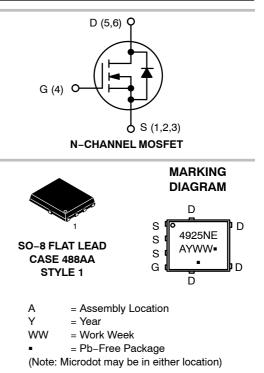
2. Surface-mounted on FR4 board using the minimum recommended pad size.



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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	$6.0~\mathrm{m}\Omega$ @ 10 V	48 A
30 V	10 mΩ @ 4.5 V	40 A



ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4925NET1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel
NTMFS4925NET3G	SO-8 FL (Pb-Free)	5000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	5.4	
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	46.3	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	136.2	°C/W
Junction-to-Ambient – (t \leq 10 s) (Note 3)	$R_{\theta JA}$	20.3	
Junction-to-Top	$R_{\theta JT}$	10.2	

3. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

4. Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = 250 μ A		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				21		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	$T_J = 25^{\circ}C$			1.0	
			$V_{DS} = 24 V$ $T_J = 125^{\circ}C$			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$				±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D =	= 250 μA	1.2	1.7	2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				3.9		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		4.0	6.0	
			I _D = 15 A		4.0		
		V _{GS} = 4.5 V	I _D = 30 A		6.4	10	mΩ
			I _D = 15 A		6.3		1
Forward Transconductance	9 FS	V_{DS} = 1.5 V, I _D) = 15 A		52		S

CHARGES, CAPACITANCES & GATE RESISTANCE

Input Capacitance	C _{ISS}		1264	
Output Capacitance	C _{OSS}	V_{GS} = 0 V, f = 1 MHz, V_{DS} = 15 V	483	pF
Reverse Transfer Capacitance	C _{RSS}		143	
Total Gate Charge	Q _{G(TOT)}		10.8	
Threshold Gate Charge	Q _{G(TH)}		2.0	nC
Gate-to-Source Charge	Q _{GS}	V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 30 A	3.8	nc
Gate-to-Drain Charge	Q _{GD}		4.2	
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 10 V, V_{DS} = 15 V; I_{D} = 30 A	21.5	nC

SWITCHING CHARACTERISTICS (Note 6)

Turn–On Delay Time	t _{d(ON)}		9.5	
Rise Time	t _r	V _{GS} = 4.5 V, V _{DS} = 15 V,	32.7	20
Turn-Off Delay Time	t _{d(OFF)}	$I_{\rm D}$ = 15 A, $R_{\rm G}$ = 3.0 Ω	16.4	ns
Fall Time	t _f		6.2	

 $\begin{array}{ll} \text{5. Pulse Test: pulse width} \leq 300 \ \mu\text{s} \text{, duty cycle} \leq 2\%. \\ \text{6. Switching characteristics are independent of operating junction temperatures.} \end{array}$

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (No	ote 6)						
Turn-On Delay Time	t _{d(ON)}	V _{GS} = 10 V, V _{DS} = 15 V,			7.4		
Rise Time	tr				27.5		1
Turn-Off Delay Time	t _{d(OFF)}	$I_{\rm D} = 15 \rm A, R_{\rm G}$	= 3.0 Ω		20.3		ns
Fall Time	t _f				4.1		
DRAIN-SOURCE DIODE CHARACTE	ERISTICS						
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V, \\ I_{S} = 30 A \\ T_{J} = 125^{\circ}C \\ T_{J} = 125^{\circ}C$		0.86	1.1	v	
				0.75			
Reverse Recovery Time	t _{RR}				25.8		
Charge Time	t _a	V _{GS} = 0 V, dIS/dt	= 100 A/μs,		12.4		ns
Discharge Time	t _b	I _S = 30	A		13.4		
Reverse Recovery Charge	Q _{RR}	1			13.6		nC
PACKAGE PARASITIC VALUES							
Source Inductance	LS	T _A = 25°C			1.00		nH
Drain Inductance	L _D				0.005		nH
Gate Inductance	L _G				1.84		nH

0.8

2.2

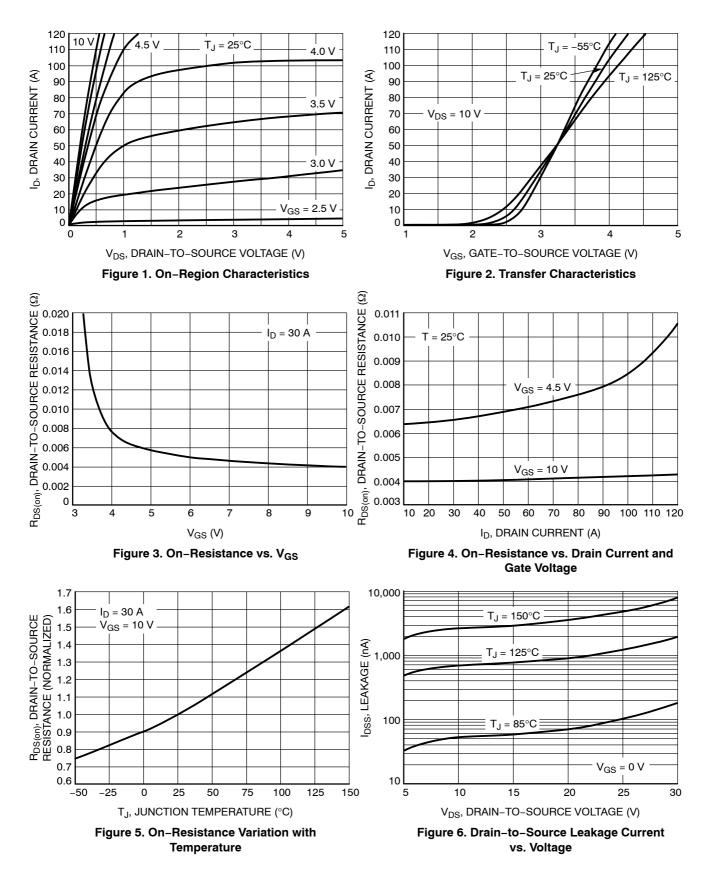
Ω

Gate Resistance

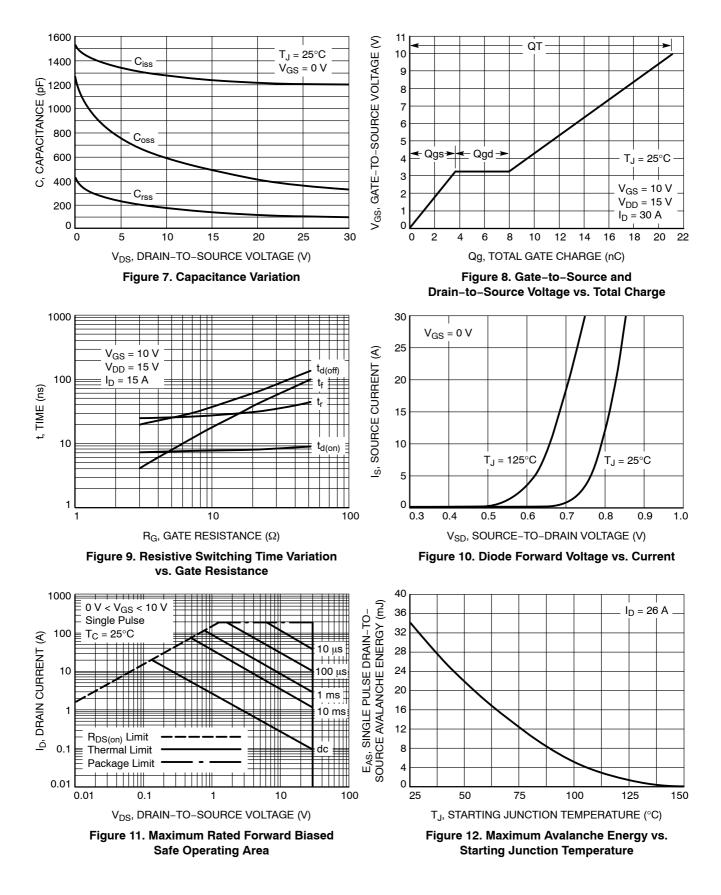
 $\begin{array}{ll} \text{5. Pulse Test: pulse width} \leq 300 \ \mu\text{s} \text{, duty cycle} \leq 2\%. \\ \text{6. Switching characteristics are independent of operating junction temperatures.} \end{array}$

 R_G

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

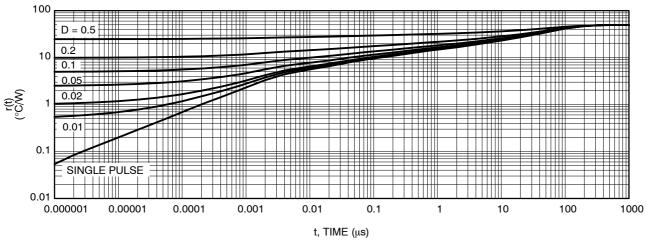
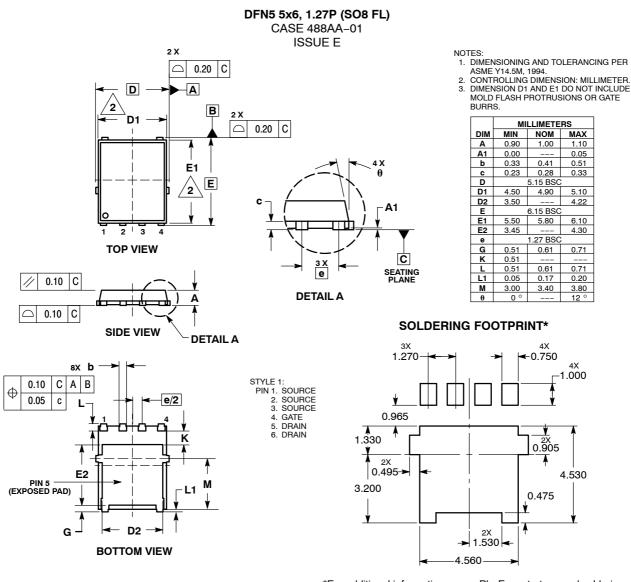


Figure 13. Thermal Response

PACKAGE DIMENSIONS



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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